

<b>Notice of References Cited</b>	Application/Control No. 10/556,344	Applicant(s)/Patent Under Reexamination YOON ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0138974	06-2005	Ha et al.	068/023.00R
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	O					
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**NON-PATENT DOCUMENTS**

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